



MOSFET

Metall Oxide Semiconductor Field Effect Transistor

CoolMOS E6

650V CoolMOSTM E6 Power Transistor
IPx65R600E6

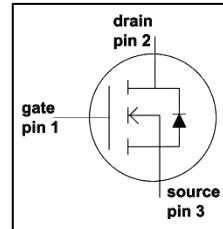
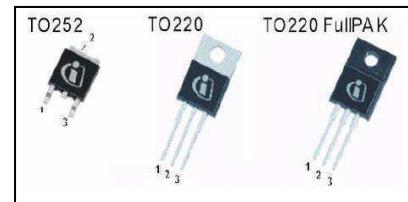
Data Sheet

Rev. 2.4
Final

Power Management & Multimarket

1 Description

CoolMOS™ is a revolutionary technology for high voltage power MOSFETs, designed according to the superjunction (SJ) principle and pioneered by Infineon Technologies. CoolMOS™ DE series combines the experience of the leading SJ MOSFET supplier with high class innovation. The resulting devices provide all benefits of a fast switching SJ MOSFET while not sacrificing ease of use. Extremely low switching and conduction losses make switching applications even more efficient, more compact, lighter, and cooler.



Features

- Extremely low losses due to very low FoM $R_{dson} \cdot Q_g$ and E_{oss}
- Very high commutation ruggedness
- Easy to use/drive, Pb-free plating, Halogen free mold compound
- Fully qualified according to JEDEC for Industrial Applications

Applications

PFC stages, hard switching PWM stages and resonant switching PWM stages e.g. PC Silverbox, Adapter, LCD & PDP TV, Lightning, Server, Telecom and UPS.

Please note: For MOSFET paralleling the use of ferrite beads on the gate or separate totem poles is generally recommended.



Table 1 Key Performance Parameters

Parameter	Value	Unit
$V_{DS} @ T_{J\max}$	700	V
$R_{DS(on),\max}$	0.6	Ω
$Q_{G,\text{typ}}$	23	nC
$I_{D,\text{pulse}}$	18	A
$E_{oss} @ 400V$	2	μJ
Body diode dI/dt	500	A/ μs

Type / Ordering Code	Package	Marking	Related links
IPD65R600E6	PG-T0252		IFX CoolMOS Webpage
IPP65R600E6	PG-T0220		IFX Design tools
IPA65R600E6	PG-T0220 FullPAK	65E6600	

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2 Maximum ratings

At $T_j = 25^\circ\text{C}$, unless otherwise specified.

Table 2 Maximum ratings

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Continuous drain current ¹⁾	I_D	—	—	7.3	A	$T_C = 25^\circ\text{C}$
		—	—	4.6		$T_C = 100^\circ\text{C}$
Pulsed drain current ²⁾	$I_{D, \text{pulse}}$	—	—	18		$T_C = 25^\circ\text{C}$
Avalanche energy, single pulse	E_{AS}	—	—	142	mJ	$I_D = 1.3\text{ A}; V_{DD} = 50\text{V}; T_C = 25^\circ\text{C}$ (see Table 21)
Avalanche energy, repetitive	E_{AR}	—	—	0.21		$I_D = 1.3\text{ A}, V_{DD}=50\text{V}$
Avalanche current, repetitive	I_{AR}	—	—	1.3	A	
MOSFET dv/dt ruggedness	dv/dt	—	—	50	V/ns	$V_{DS}=0\dots 480\text{ V}$
Gate source voltage	V_{GS}	-20	—	20	V	<i>static</i>
		-30	—	30		AC ($f > 1\text{ Hz}$)
Power dissipation for Non FullPAK	P_{tot}	—	—	63	W	$T_C = 25^\circ\text{C}$
Power dissipation for FullPAK	P_{tot}	—	—	28	W	$T_C = 25^\circ\text{C}$
Operating and storage temperature	T_j, T_{stg}	-55	—	150	°C	
Mounting torque TO-220		—	—	60	Ncm	<i>M3 and M3.5 screws</i>
Mounting torque TO-220 FullPAK		—	—	50		<i>M2.5 Screws</i>
Continuous diode forward current	I_S	—	—	6.3	A	$T_C = 25^\circ\text{C}$
Diode pulse current ²⁾	$I_{S, \text{pulsed}}$	—	—	18	A	$T_C = 25^\circ\text{C}$
Reverse diode dv/dt ³⁾	dv/dt	—	—	15	V/ns	$V_{DS}=0\dots 480\text{ V}, I_{SD} \leq I_D, T_C = 125^\circ\text{C}$ (see table 22)
Maximum diode commutation speed ³⁾	di_f/dt			500	A/μs	

1) Limited by $T_{j, \text{max}}$. Maximum duty cycle D=0.75

2) Pulse width t_p limited by $T_{j, \text{max}}$

3) Identical low side and high side switch with identical R_G

3 Thermal characteristics

Table 3 Thermal characteristics TO-220 (IPP65R600E6)

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Thermal resistance, junction-case	R_{thJC}	—	—	2.0	°C/W	
Thermal resistance, junction-ambient	R_{thJA}	—	—	62		leaded
Soldering temperature, wavesoldering only allowed at leads	T_{sold}	—	—	260	°C	1.6mm (0.063 in.) from case for 10 s

Table 4 Thermal characteristics TO-220 FullPAK (IPA65R600E6)

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Thermal resistance, junction-case	R_{thJC}	—	—	4.5	°C/W	
Thermal resistance, junction-ambient	R_{thJA}	—	—	80		leaded
Soldering temperature, wavesoldering only allowed at leads	T_{sold}	—	—	260	°C	1.6mm (0.063 in.) from case for 10 s

Table 5 Thermal characteristics TO-252 (IPD65R600E6)

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Thermal resistance, junction-case	R_{thJC}	—	—	2.0	°C/W	
Thermal resistance, junction-ambient	R_{thJA}	—	—	62		SMD version, device on PCB, minimal footprint
			35			SMD version, device on PCB, 6cm² cooling area ¹⁾
Soldering temperature, wave- & reflowsoldering only allowed	T_{sold}	—	—	260	°C	Reflow MSL1

1) Device on 40mm*40mm*1.5 epoxy PCB FR4 with 6cm² (one layer, 70µm thick) copper area for drain connection. PCB is vertical without air stream cooling.

4 Electrical characteristics

Electrical characteristics, at $T_j=25^\circ\text{C}$, unless otherwise specified

Table 6 Static characteristics

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Drain-source Breakdown voltage	$V_{(BR)DSS}$	650	—	—	V	$V_{GS}= 0V, I_D= 1.0mA$
Gate threshold voltage	$V_{GS(th)}$	2.5	3	3.5		$V_{DS}= V_{GS}, I_D= 0.21mA$
Zero gate Voltage drain current	I_{DSS}	—	—	1	μA	$V_{DS}=600 \text{ V}, V_{GS}=0V, T_j=25^\circ\text{C}$
		—	10	—		$V_{DS}=600 \text{ V}, V_{GS}=0V, T_j=150^\circ\text{C}$
Gate- source leakage current	I_{GSS}	—	—	100	nA	$V_{GS}= 20V, V_{DS}= 0V$
Drain- source on- state resistance	$R_{DS(on)}$	—	0.54	0.6	Ω	$V_{GS}= 10V, I_D=2.1A, T_j= 25^\circ\text{C}$
		—	1.40	—		$V_{GS}= 10V, I_D=2.1A, T_j= 150^\circ\text{C}$
Gate resistance	R_G	—	10.5	—	Ω	$f= 1\text{MHz, open drain}$

Table 7 Dynamic characteristics

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Input capacitance	C_{iss}	—	440	—	pF	$V_{GS}= 0V, V_{DS}= 100V, f= 1\text{MHz}$
Output capacitance	C_{oss}	—	30	—		
Effective output capacitance, energy related ¹⁾	$C_{o(er)}$	—	21	—		$V_{GS}= 0V, V_{DS}=0\dots480V$
Effective output capacitance, time related ²⁾	$C_{o(tr)}$	—	88	—		$I_D= \text{const}$ $V_{GS}= 0V, V_{DS}=0\dots480 V$
Turn- on delay time	$t_{d(on)}$	—	10	—	ns	$V_{DD}=400 V$
Rise time	t_r	—	8	—		$V_{GS}=13 V, I_D=3.2A,$
Turn- off delay time	$t_{d(off)}$	—	64	—		$R_G= 6.8 \Omega$
Fall time	t_f	—	11	—		(see table 20)

1) $C_{o(er)}$ is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 80% $V_{(BR)DSS}$

2) $C_{o(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% $V_{(BR)DSS}$

Table 8 Gate charge characteristics

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Gate to source charge	Q_{GS}	—	2.75	—	nC	$V_{DD}= 480V, I_D= 3.2A,$ $V_{GS}=0$ to 10 V
Gate to drain charge	Q_{GD}	—	12	—		
Gate charge, total	Q_G	—	23	—		
Gate plateau voltage	$V_{plateau}$	—	5.5	—	V	

Table 8 Reverse diode characteristics

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Diode forward voltage	V_{SD}	—	0.9	—	V	$V_{GS}=0V, I_F=3.2A,$ $T_f=25^\circ C$
Reverse recovery time	t_{rr}	—	270	—	ns	$V_R=400 V, I_F=3.2A,$ $dI/dt=100 A/\mu s$ (see table 22)
Reverse recovery charge	Q_{rr}	—	2.0	—	nC	
Peak reverse recovery current	I_{rrm}	—	13	—	A	

5 Electrical characteristics diagrams

Table 10

Power dissipation Non FullPAK	Power dissipation FULLPAK
$P_{tot} = f(T_c)$	$P_{tot} = f(T_c)$

Table 11

Max. transient thermal impedance Non FullPAK	Max. transient thermal impedance Non FullPAK
$Z_{(thJC)} = f(t_p)$; parameter: $D = t_p/T$	$Z_{(thJC)} = f(t_p)$; parameter: $D = t_p/T$

Table 12

Safe operating area $T_C=25^\circ\text{C}$ Non FullPAK	Safe operating area $T_C=25^\circ\text{C}$ FullPAK
<p>The graph plots drain current I_D [A] on a logarithmic y-axis (from 10^{-2} to 10^2) against drain-to-source voltage V_{DS} [V] on a logarithmic x-axis (from 10^0 to 10^3). Six curves are shown for pulse times of 1 ns, 10 ns, 100 ns, 1 ms, 10 ms, and DC. A note indicates the curves are limited by on-state resistance.</p>	<p>The graph plots drain current I_D [A] on a logarithmic y-axis (from 10^{-2} to 10^2) against drain-to-source voltage V_{DS} [V] on a logarithmic x-axis (from 10^0 to 10^3). Six curves are shown for pulse times of 1 ns, 10 ns, 100 ns, 1 ms, 10 ms, and DC. A note indicates the curves are limited by on-state resistance.</p>
$I_D=f(V_{DS})$; $T_C=25^\circ\text{C}$; $V_{GS} > 7\text{V}$; $D=0$; parameter t_p	$I_D=f(V_{DS})$; $T_C=25^\circ\text{C}$; $V_{GS} > 7\text{V}$; $D=0$; parameter t_p

Table 13

Safe operating area $T_C=80^\circ\text{C}$ Non FullPAK	Safe operating area $T_C=80^\circ\text{C}$ FullPAK
<p>The graph plots drain current I_D [A] on a logarithmic y-axis (from 10^{-2} to 10^2) against drain-to-source voltage V_{DS} [V] on a logarithmic x-axis (from 10^0 to 10^3). Six curves are shown for pulse times of 1 ns, 10 ns, 100 ns, 1 ms, 10 ms, and DC.</p>	<p>The graph plots drain current I_D [A] on a logarithmic y-axis (from 10^{-2} to 10^2) against drain-to-source voltage V_{DS} [V] on a logarithmic x-axis (from 10^0 to 10^3). Six curves are shown for pulse times of 1 ns, 10 ns, 100 ns, 1 ms, 10 ms, and DC.</p>
$I_D=f(V_{DS})$; $T_C=80^\circ\text{C}$; $V_{GS} > 7\text{V}$; $D=0$; parameter t_p	$I_D=f(V_{DS})$; $T_C=80^\circ\text{C}$; $V_{GS} > 7\text{V}$; $D=0$; parameter t_p

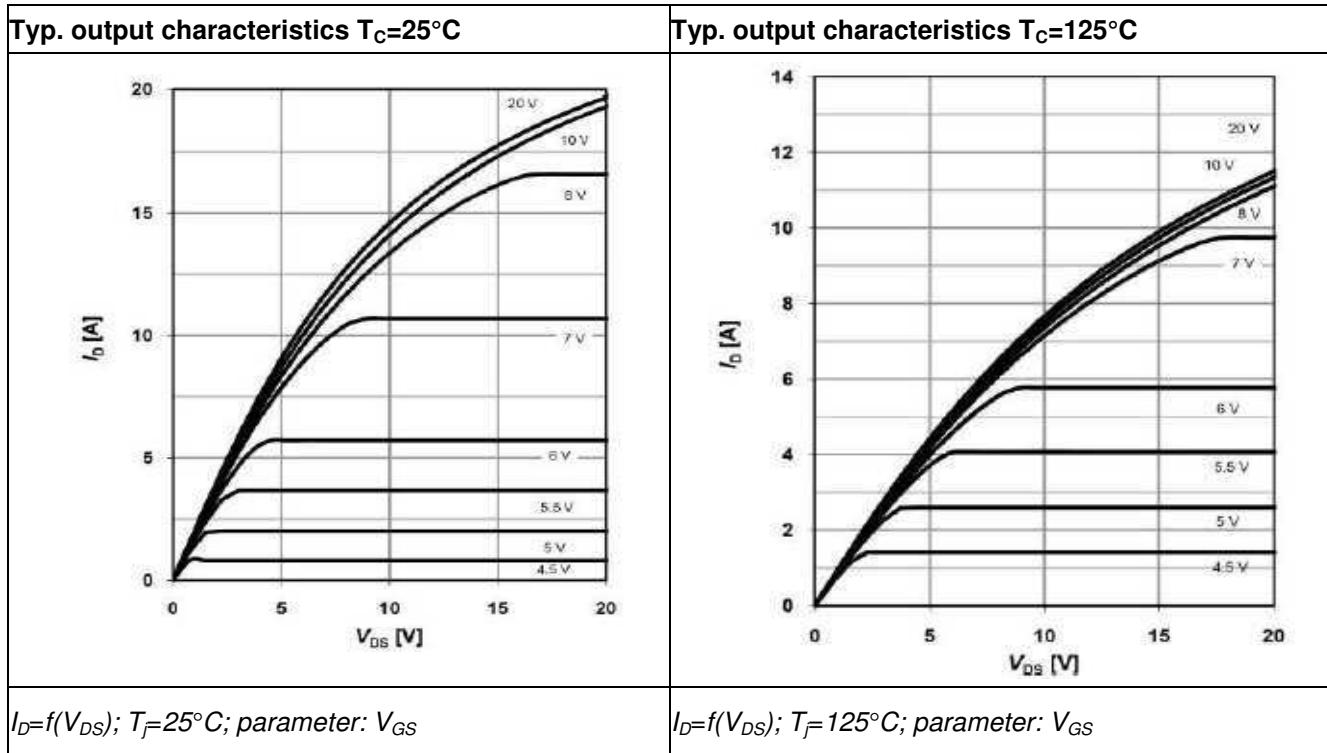
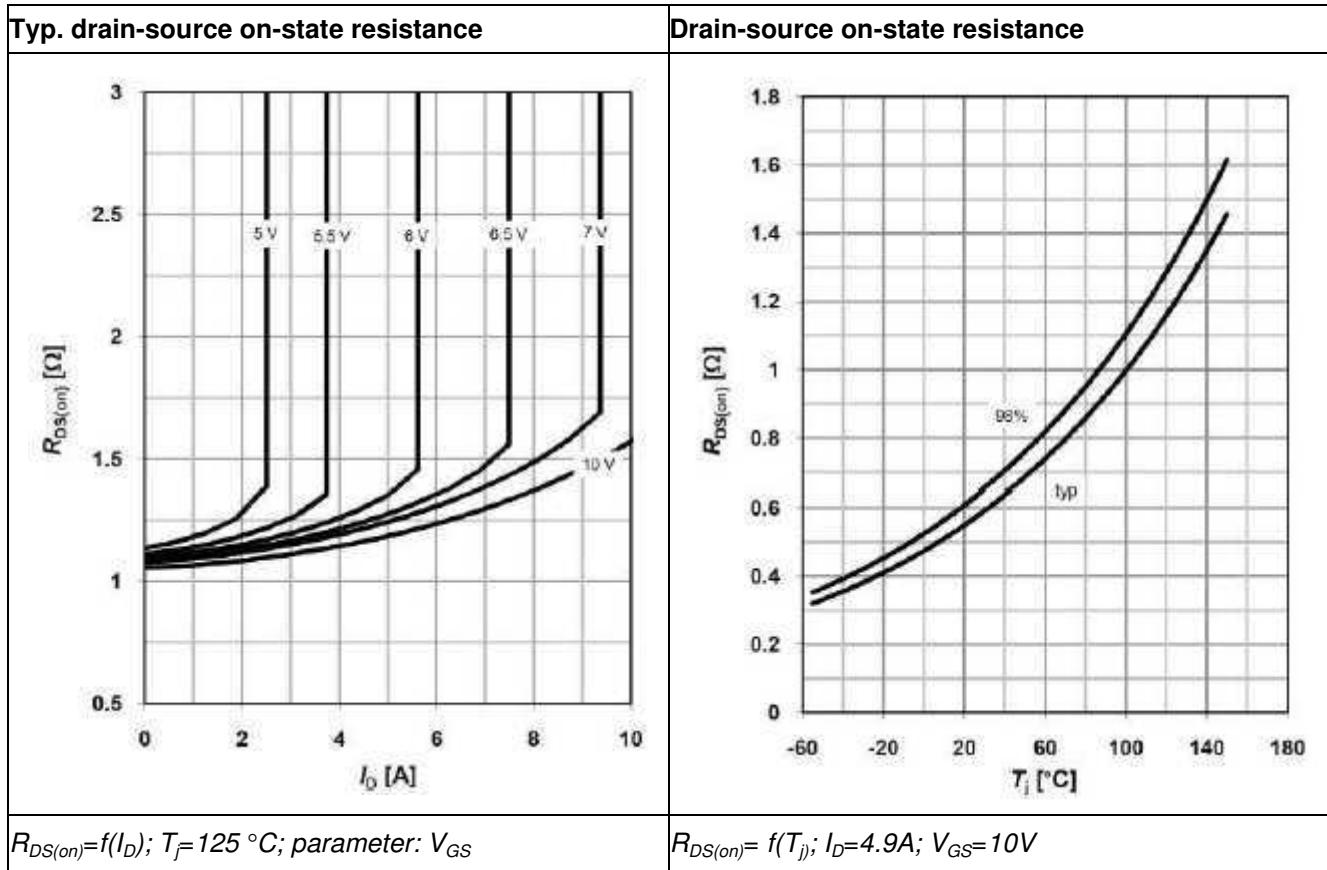
Table 14

Table 15


Table 16

Typ. transfer characteristics	Typ. gate charge
<p>$I_D=f(V_{GS})$; $V_{DS}=20V$</p>	<p>$V_{GS}=f(Q_{gate})$, $I_D=4.9\text{ A pulsed}$</p>

Table 17

Avalanche energy	Drain-source breakdown voltage
<p>$E_{AS}=f(T_j)$; $I_D=1.8\text{ A}$; $V_{DD}=50\text{ V}$</p>	<p>$V_{BR(DSS)}=f(T_j)$; $I_D=1.0\text{ mA}$</p>

Table 18

Typ. capacitances	Typ. C_{OSS} stored energy
$C=f(V_{DS})$; $V_{GS}=0$ V; $f=1$ MHz	$E_{OSS}=f(V_{DS})$

Table 19

Forward characteristics of reverse diode

$I_F=f(V_{SD})$; parameter: T_j

6 Test circuits

Table 20 Switching times test circuit and waveform for inductive load

Switching times test circuit for inductive load	Switching time waveform

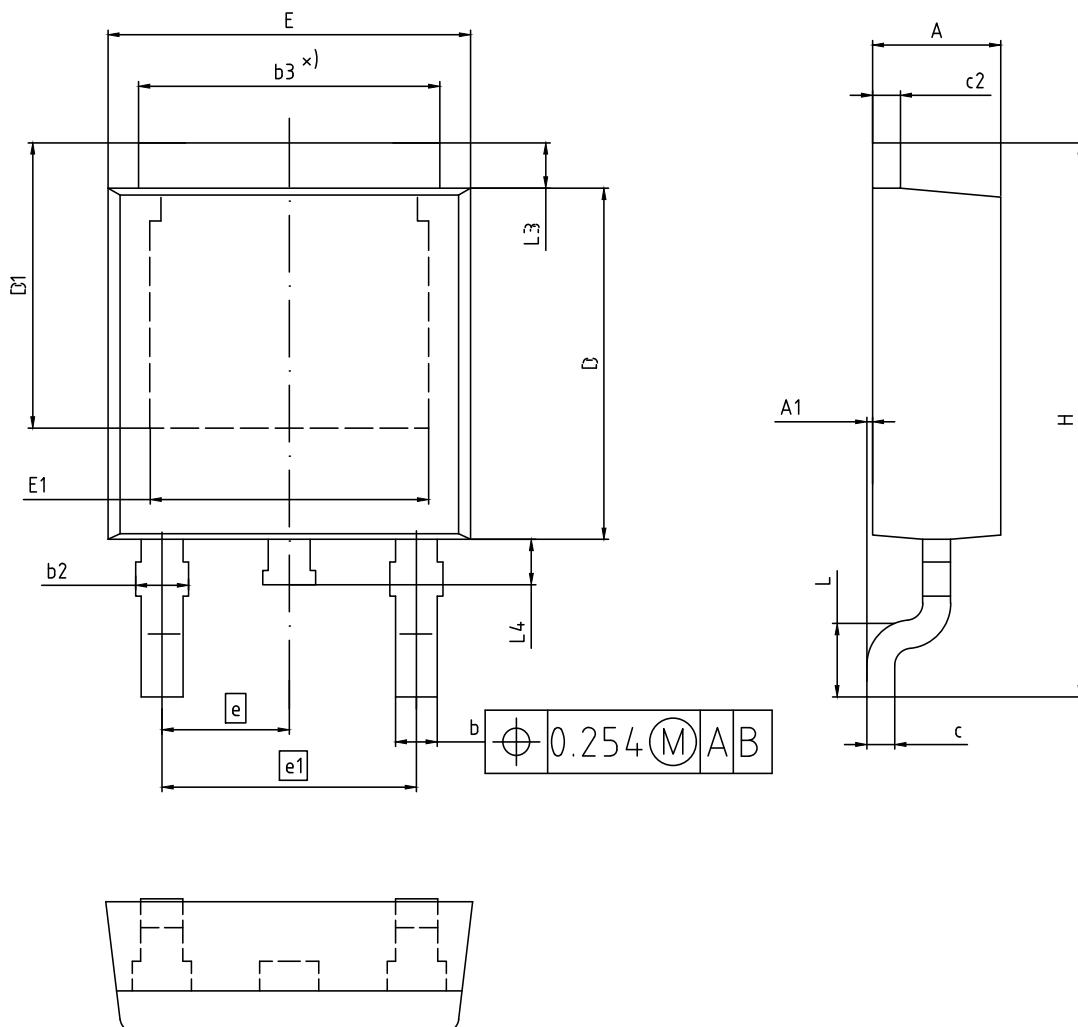
Table 21

Unclamped inductive load test circuit	Unclamped inductive waveform

Table 22

Test circuit for diode characteristics	Diode recovery waveform

7 Package outlines



ALL DIMENSIONS REFER TO JEDEC
STANDARD TO-252 AND DO NOT INCLUDE MOLD
FLASH OR PROTRUSIONS.

DIMENSION	MILLIMETERS	
	MIN.	MAX.
A	2.16	2.41
A1	0.00	0.15
b	0.64	0.89
b2	0.65	1.15
b3	4.95	5.50
c	0.46	0.61
c2	0.40	0.98
D	5.97	6.22
D1	5.02	5.84
E	6.35	6.73
E1	4.32	5.50
e	2.29	
e1	4.57	
N	3	
H	9.40	10.48
L	1.18	1.78
L3	0.89	1.27
L4	0.51	1.02

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Figure 1 Outlines TO-252, dimensions in mm

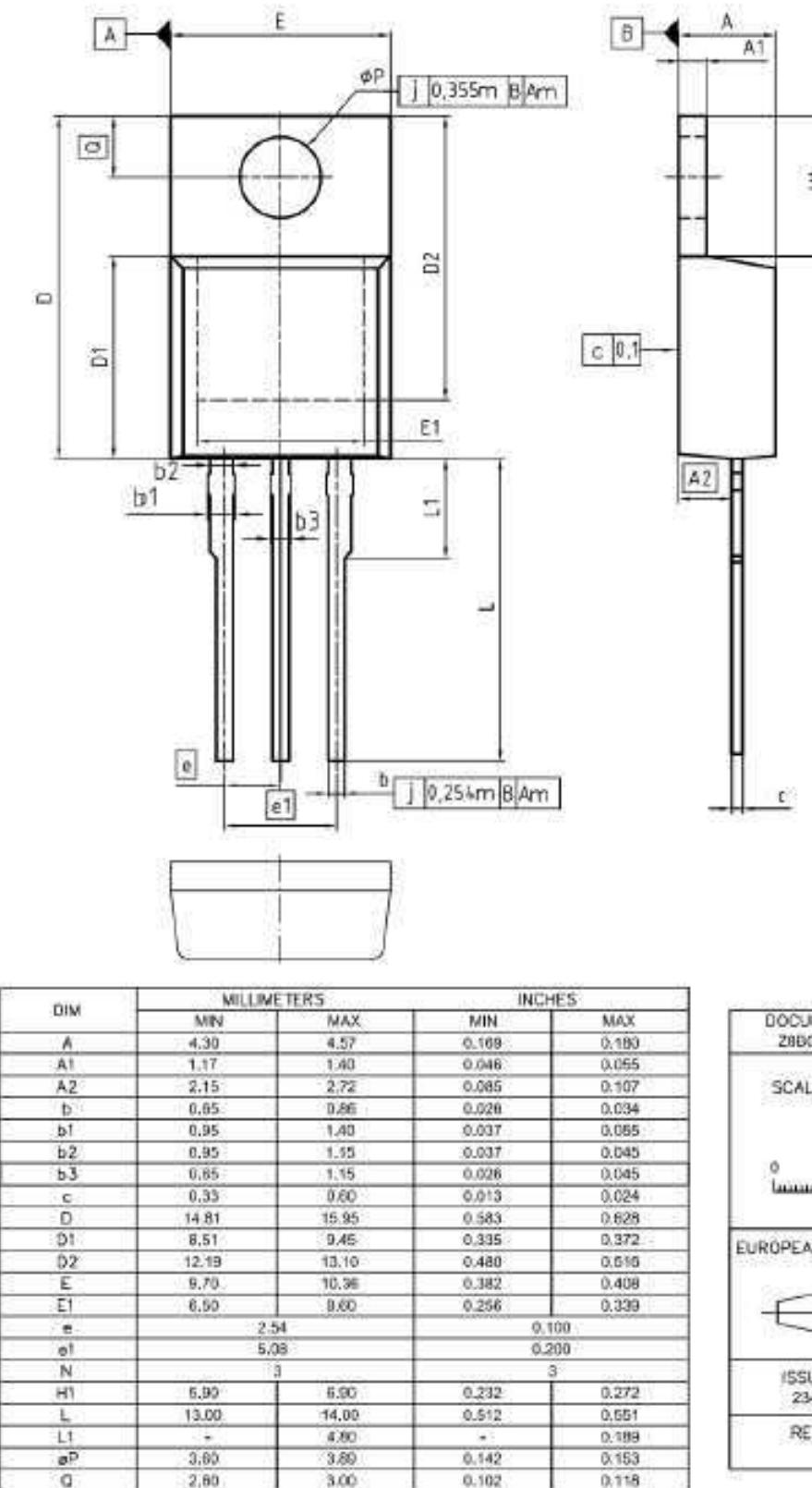


Figure 2 Outlines TO220, dimensions in mm/inches

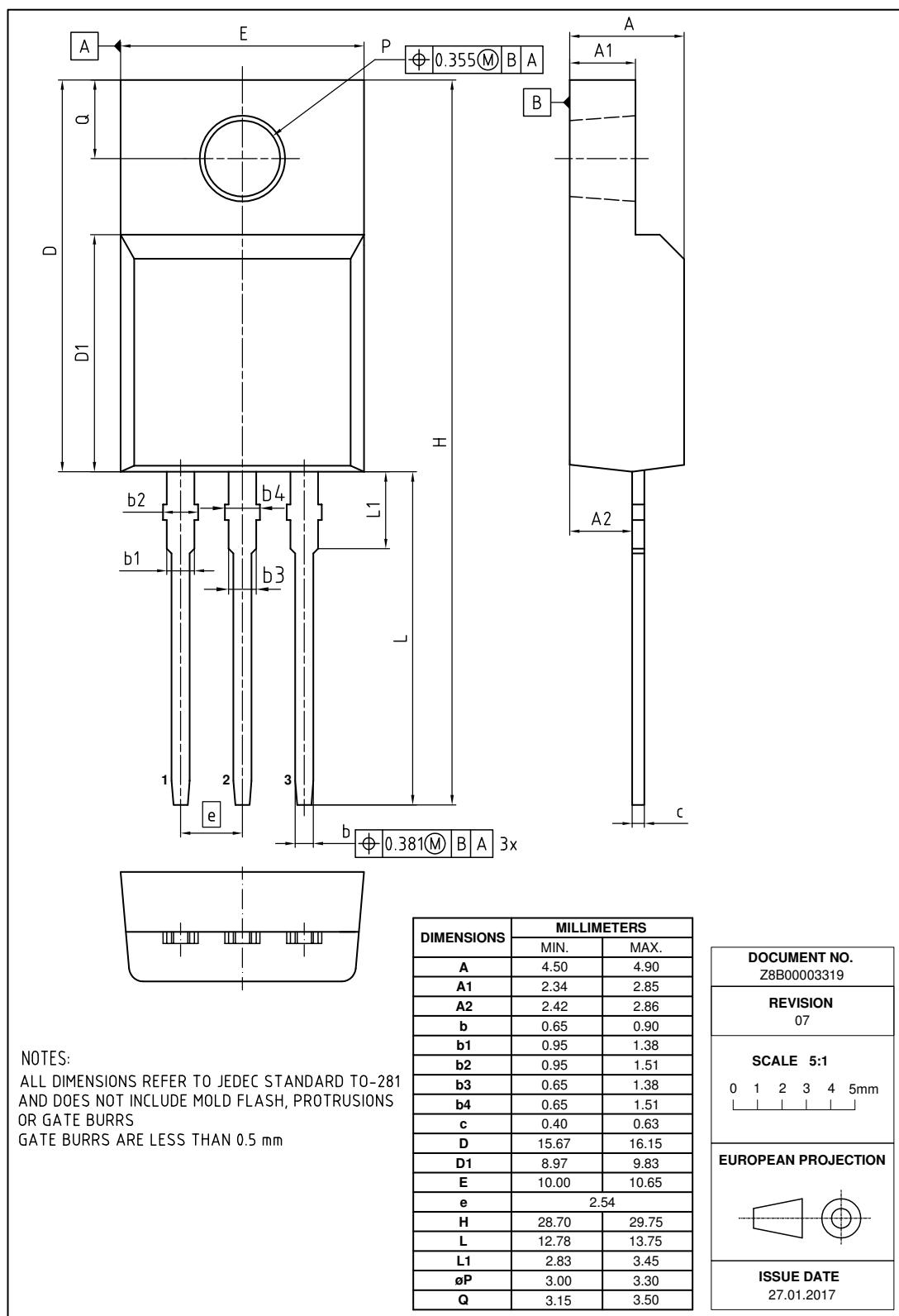


Figure 3 Outlines TO220 FullPAK, dimensions in mm

Revision History

IPx65R600E6

Revision: 2020-05-20, Rev. 2.4

Previous Revision

Revision	Date	Subjects (major changes since last revision)
2.2	2016-08-04	Revised TO220 Full PAK package drawing on page 16
2.3	2018-03-04	Outline PG-T0-220 FullPAK update
2.4	2020-05-20	Update of the package outlines TO-252

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